

Search Notes		Application/Control No.	Applicant(s)/Patent under Reexamination
		10/661,579	NAKAGAWA ET AL.
		Examiner	Art Unit
		Diem Tran	3748

SEARCHED			
Class	Subclass	Date	Examiner
60	284.	10/24/05	DT
	285		
	297		
	299		
↓	300	↓	↓
updated search 7/19/07 DT			
updated search 1/26/07 DT			
updated search 8/18/07 DT			
updated search 11/8/07 DT			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner